

Notice of References Cited	Application/Control No. 10/609,016	Applicant(s)/Patent Under Reexamination LE ET AL.	
	Examiner /BINH K. TIEU/	Art Unit 2614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0137888	07-2004	Ohki, Masahiro	455/417
*	B	US-2003/0147537	08-2003	Jing et al.	380/277
*	C	US-7,079,499	07-2006	Akhtar et al.	370/310
*	D	US-2001/0036164	11-2001	Kakemizu et al.	370/331
*	E	US-2004/0024901	02-2004	Agrawal et al.	709/238
*	F	US-2002/0120844	08-2002	Faccin et al.	713/168
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.